

<b>Notice of References Cited</b>	Application/Control No. 10/531,002	Applicant(s)/Patent Under Reexamination LIPINSKI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Li et al (Sheng Wu Hua Xue Yu Sheng Wu Wu Li Xue Bao, Shanghai, 2001, 33(3):360-364 – PMID: 12050801)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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